IGBT

High speed DuoPack: IGBT in Trench and Fieldstop technology with soft, fast recovery anti-parallel diode

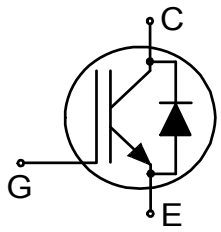
IKW25N120H3

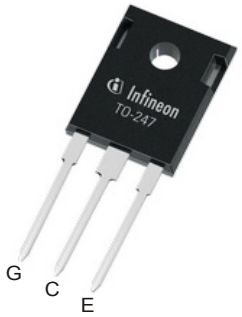
1200V high speed switching series third generation

Data sheet

Industrial Power Control

High speed DuoPack: IGBT in Trench and Fieldstop technology with soft, fast recovery anti-parallel diode





Features:

TRENCHSTOP™ technology offering
- very low V_{CEsat}
- low EMI
- Very soft, fast recovery anti-parallel diode
- maximum junction temperature 175°C
- qualified according to JEDEC for target applications
- Pb-free lead plating; RoHS compliant
- complete product spectrum and PSpice Models: http://www.infineon.com/igbt/

Applications:

- uninterruptible power supplies
- welding converters
- converters with high switching frequency

Key Performance and Package Parameters

Type	V_{CE}	I_C	V_{CEsat}, T_{vj}=25°C	T_{vjmax}	Marking	Package
IKW25N120H3	1200V	25A	2.05V	175°C	K25H1203	PG-TO247-3

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Maximum Ratings

For optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V_{CE}	1200	V
DC collector current, limited by T_{vjmax} T_C = 25°C T_C = 100°C	I_C	 50.0 25.0	A
Pulsed collector current, t_p limited by T_{vjmax}	I_{Cpuls}	100.0	A
Turn off safe operating area $V_{CE} \le 1200V$, $T_{vj} \le 175°C$	-	100.0	A
Diode forward current, limited by T_{vjmax} T_C = 25°C T_C = 100°C	I_F	 25.0 12.5	A
Diode pulsed current, t_p limited by T_{vjmax}	I_{Fpuls}	100.0	A
Gate-emitter voltage	V_{GE}	±20	V
Short circuit withstand time V_{GE} = 15.0V, $V_{CC} \le 600V$ Allowed number of short circuits < 1000 Time between short circuits: ≥ 1.0s T_{vj} = 175°C	t_{SC}	 10	µs
Power dissipation T_C = 25°C Power dissipation T_C = 100°C	P_{tot}	326.0 156.0	W
Operating junction temperature	T_{vj}	-40...+175	°C
Storage temperature	T_{stg}	-55...+150	°C
Soldering temperature, wave soldering 1.6mm (0.063in.) from case for 10s		260	°C
Mounting torque, M3 screw Maximum of mounting processes: 3	M	0.6	Nm

Thermal Resistance

Parameter	Symbol	Conditions	Max. Value	Unit
Characteristic				
IGBT thermal resistance, junction - case	$R_{th(j-c)}$		0.46	K/W
Diode thermal resistance, junction - case	$R_{th(j-c)}$		1.49	K/W
Thermal resistance junction - ambient	$R_{th(j-a)}$		40	K/W

Electrical Characteristic, at T_{vj} = 25°C, unless otherwise specified

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Static Characteristic						
Collector-emitter breakdown voltage	$V_{(BR)CES}$	V_{GE} = 0V, I_C = 0.50mA	1200	-	-	V
Collector-emitter saturation voltage	V_{CEsat}	V_{GE} = 15.0V, I_C = 25.0A T_{vj} = 25°C T_{vj} = 125°C T_{vj} = 175°C	 - - -	 2.05 2.50 2.70	 2.40 - -	V
Diode forward voltage	V_F	V_{GE} = 0V, I_F = 12.5A T_{vj} = 25°C T_{vj} = 175°C	 - -	 1.80 1.85	 2.35 -	V
Diode forward voltage	V_F	V_{GE} = 0V, I_F = 25.0A T_{vj} = 25°C T_{vj} = 125°C T_{vj} = 175°C	 - - -	 2.40 2.60 2.60	 3.05 - -	V
Gate-emitter threshold voltage	$V_{GE(th)}$	I_C = 0.85mA, V_{CE} = V_{GE}	5.0	5.8	6.5	V
Zero gate voltage collector current	I_{CES}	V_{CE} = 1200V, V_{GE} = 0V T_{vj} = 25°C T_{vj} = 175°C	 - -	 - -	 250.0 2500.0	µA
Gate-emitter leakage current	I_{GES}	V_{CE} = 0V, V_{GE} = 20V	-	-	600	nA
Transconductance	g_{fs}	V_{CE} = 20V, I_C = 25.0A	-	13.0	-	S

Electrical Characteristic, at T_{vj} = 25°C, unless otherwise specified

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Dynamic Characteristic						
Input capacitance	C_{ies}	V_{CE} = 25V, V_{GE} = 0V, f = 1MHz	-	1430	-	pF
Output capacitance	C_{oes}		-	115	-	
Reverse transfer capacitance	C_{res}		-	75	-	
Gate charge	Q_G	V_{CC} = 960V, I_C = 25.0A, V_{GE} = 15V	-	115.0	-	nC
Internal emitter inductance measured 5mm (0.197 in.) from case	L_E		-	13.0	-	nH
Short circuit collector current Max. 1000 short circuits Time between short circuits: ≥ 1.0s	$I_{C(SC)}$	V_{GE} = 15.0V, V_{CC} ≤ 600V, t_{SC} ≤ 10µs T_{vj} = 175°C	-	87	-	A

Switching Characteristic, Inductive Load

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
IGBT Characteristic, at T_{vj} = 25°C						
Turn-on delay time	$t_{d(on)}$	T_{vj} = 25°C, V_{CC} = 600V, I_C = 25.0A, V_{GE} = 0.0/15.0V, $R_{G(on)}$ = 23.0Ω, $R_{G(off)}$ = 23.0Ω, $L\sigma$ = 80nH, $C\sigma$ = 67pF $L\sigma$, $C\sigma$ from Fig. E Energy losses include “tail” and diode reverse recovery.	-	27	-	ns
Rise time	t_r		-	41	-	ns
Turn-off delay time	$t_{d(off)}$		-	277	-	ns
Fall time	t_f		-	17	-	ns
Turn-on energy	E_{on}		-	1.80	-	mJ
Turn-off energy	E_{off}		-	0.85	-	mJ
Total switching energy	E_{ts}		-	2.65	-	mJ

Diode Characteristic, at T_{vj} = 25°C

Diode reverse recovery time	t_{rr}	T_{vj} = 25°C, V_R = 600V, I_F = 25.0A, di_F/dt = 500A/µs	-	290	-	ns
Diode reverse recovery charge	Q_{rr}		-	1.20	-	µC
Diode peak reverse recovery current	I_{rrm}		-	10.4	-	A
Diode peak rate of fall of reverse recovery current during t_b	di_{rr}/dt		-	-150	-	A/µs

Switching Characteristic, Inductive Load

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
IGBT Characteristic, at T_{vj} = 175°C						
Turn-on delay time	$t_{d(on)}$	T_{vj} = 175°C, V_{CC} = 600V, I_C = 25.0A, V_{GE} = 0.0/15.0V, $R_{G(on)}$ = 23.0Ω, $R_{G(off)}$ = 23.0Ω, $L\sigma$ = 80nH, $C\sigma$ = 67pF $L\sigma$, $C\sigma$ from Fig. E Energy losses include “tail” and diode reverse recovery.	-	26	-	ns
Rise time	t_r		-	35	-	ns
Turn-off delay time	$t_{d(off)}$		-	347	-	ns
Fall time	t_f		-	50	-	ns
Turn-on energy	E_{on}		-	2.60	-	mJ
Turn-off energy	E_{off}		-	1.70	-	mJ
Total switching energy	E_{ts}		-	4.30	-	mJ

Diode Characteristic, at T_{vj} = 175°C

Diode reverse recovery time	t_{rr}	T_{vj} = 175°C, V_R = 600V, I_F = 25.0A, di_F/dt = 500A/µs	-	505	-	ns
Diode reverse recovery charge	Q_{rr}		-	2.75	-	µC
Diode peak reverse recovery current	I_{rrm}		-	12.8	-	A
Diode peak rate of fall of reverse recovery current during t_b	di_{rr}/dt		-	-85	-	A/µs

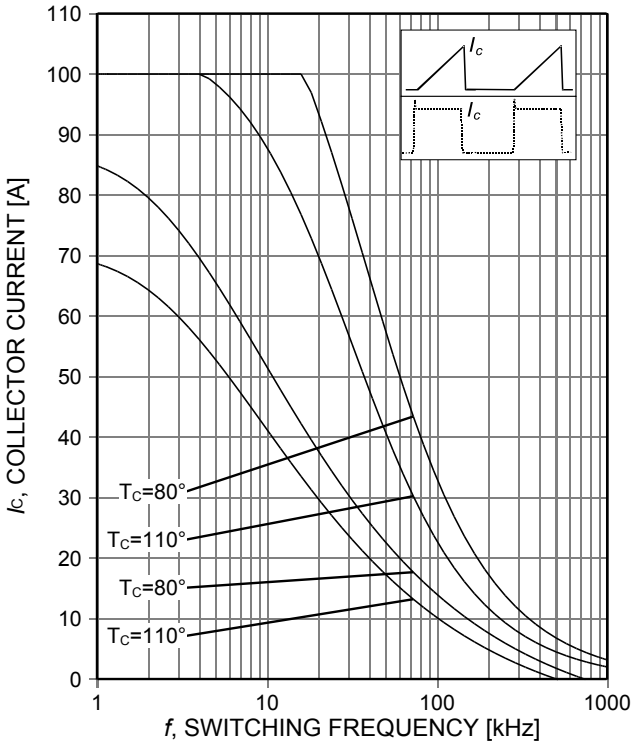

Figure 1. **Collector current as a function of switching frequency**
(T_j≤175°C, D=0.5, V_{CE}=600V, V_{GE}=15/0V, r_G=23Ω)

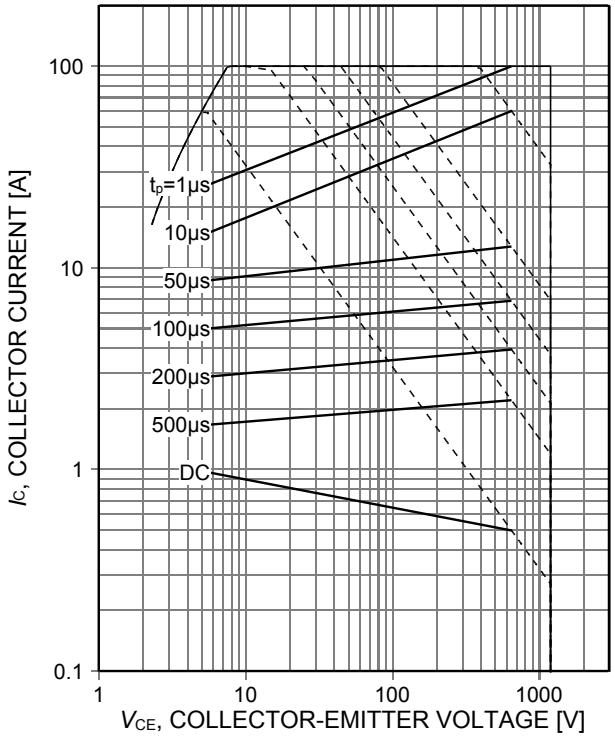

Figure 2. **Forward bias safe operating area**
(D=0, T_C=25°C, T_j≤175°C; V_{GE}=15V)

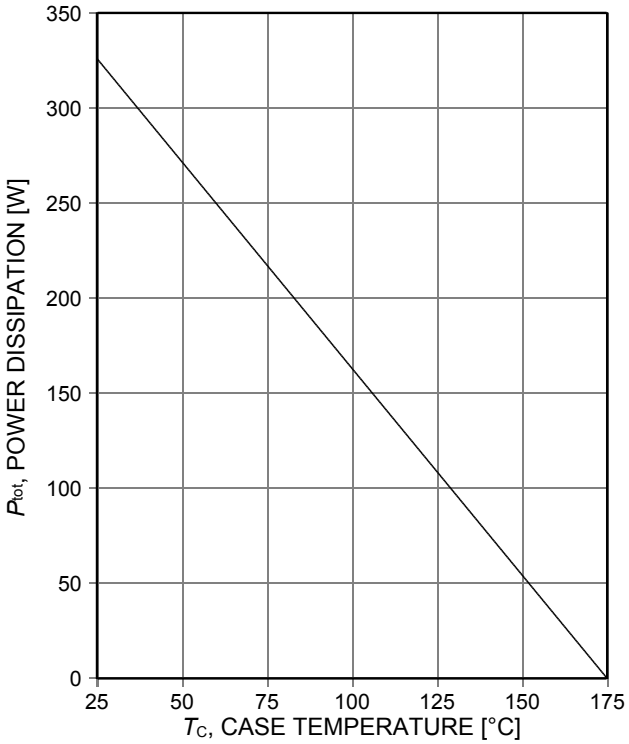

Figure 3. **Power dissipation as a function of case temperature**
(T_j≤175°C)

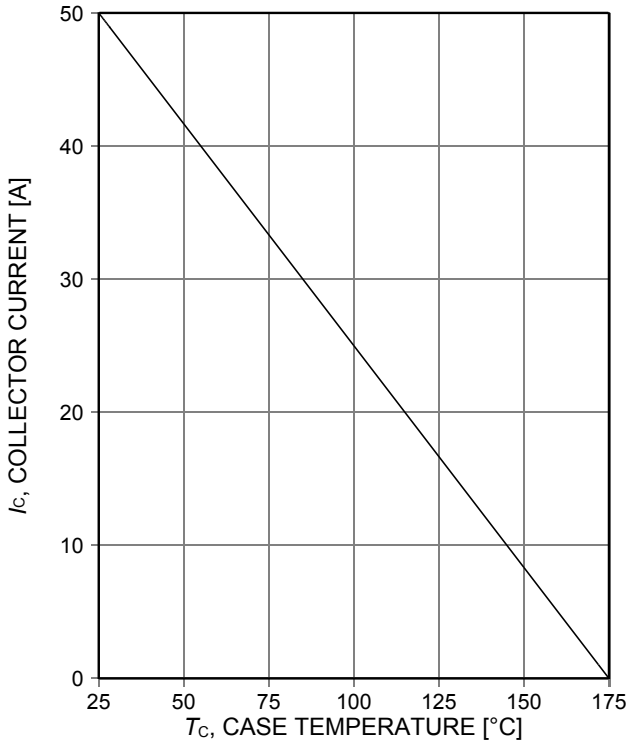

Figure 4. **Collector current as a function of case temperature**
(V_{GE}≥15V, T_j≤175°C)

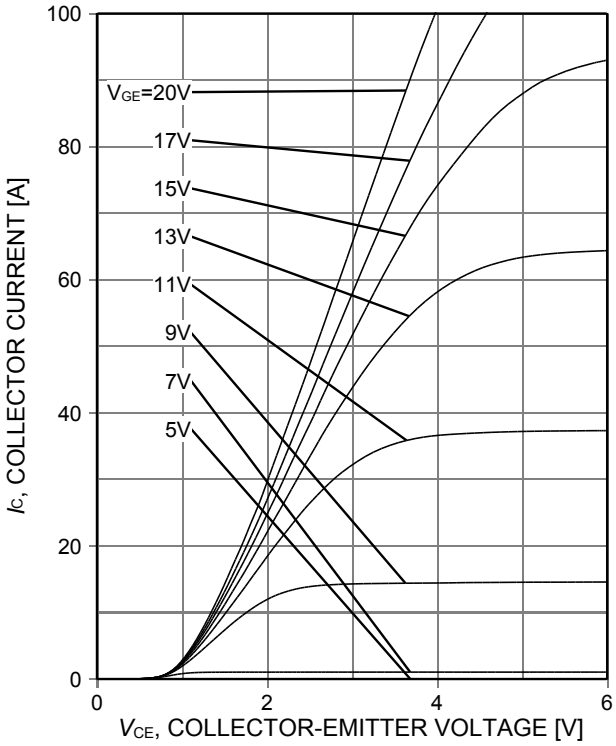

Figure 5. **Typical output characteristic** (T_j=25°C)

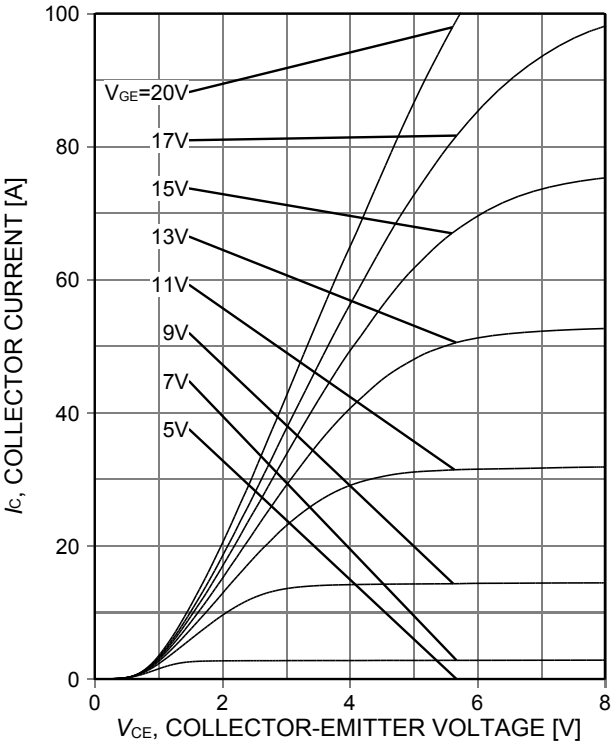

Figure 6. **Typical output characteristic** (T_j=175°C)

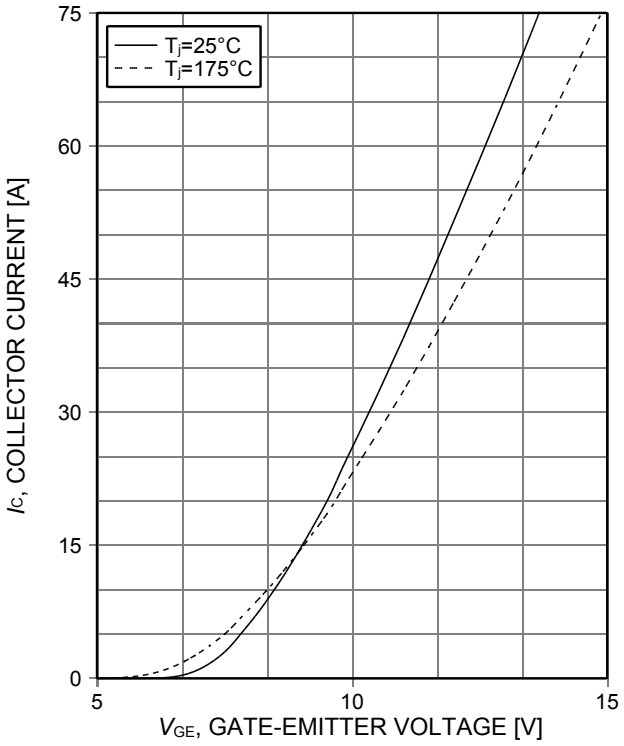

Figure 7. **Typical transfer characteristic** (V_{CE}=20V)

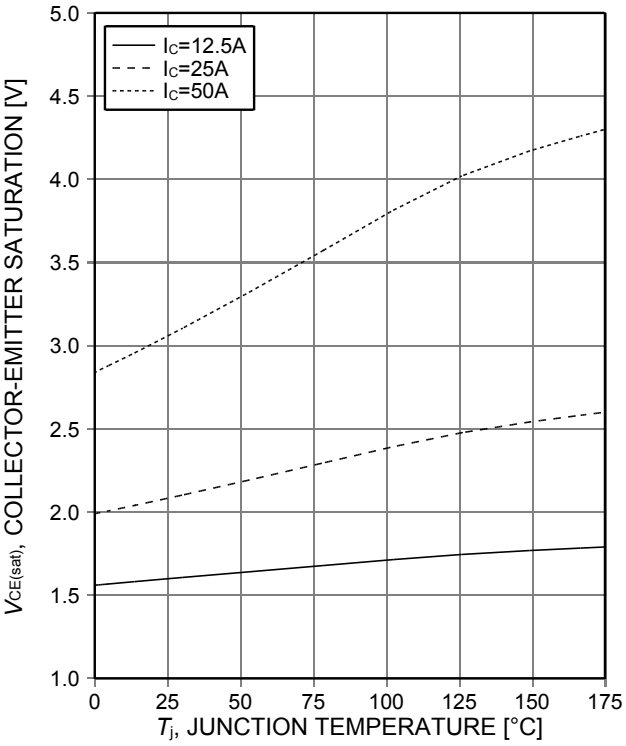

Figure 8. **Typical collector-emitter saturation voltage as a function of junction temperature** (V_{GE}=15V)

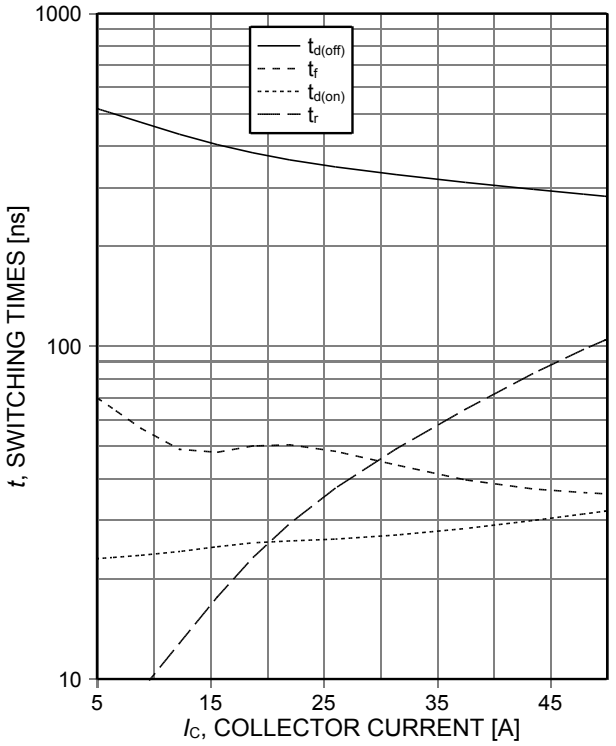

Figure 9. **Typical switching times as a function of collector current**
(ind. load, T_j=175°C, V_{CE}=600V, V_{GE}=15/0V, r_G=23Ω, test circuit in Fig. E)

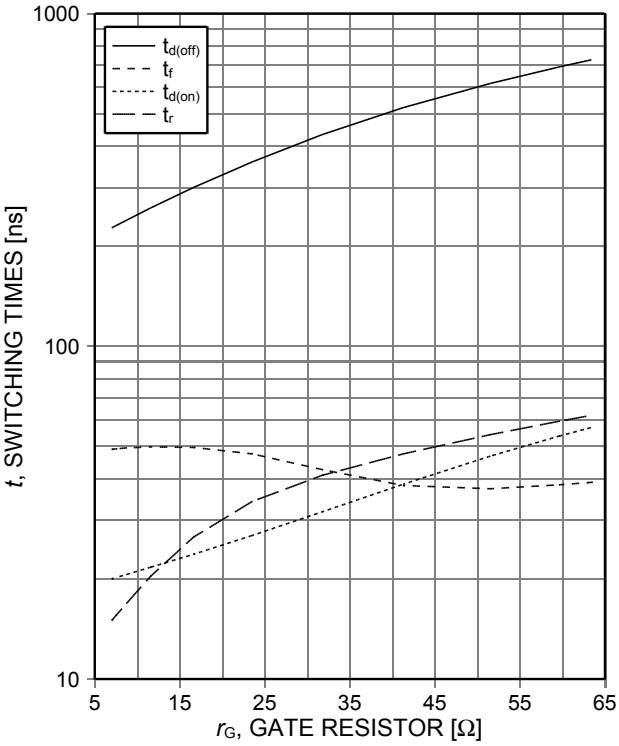

Figure 10. **Typical switching times as a function of gate resistor**
(ind. load, T_j=175°C, V_{CE}=600V, V_{GE}=15/0V, I_C=25A, test circuit in Fig. E)

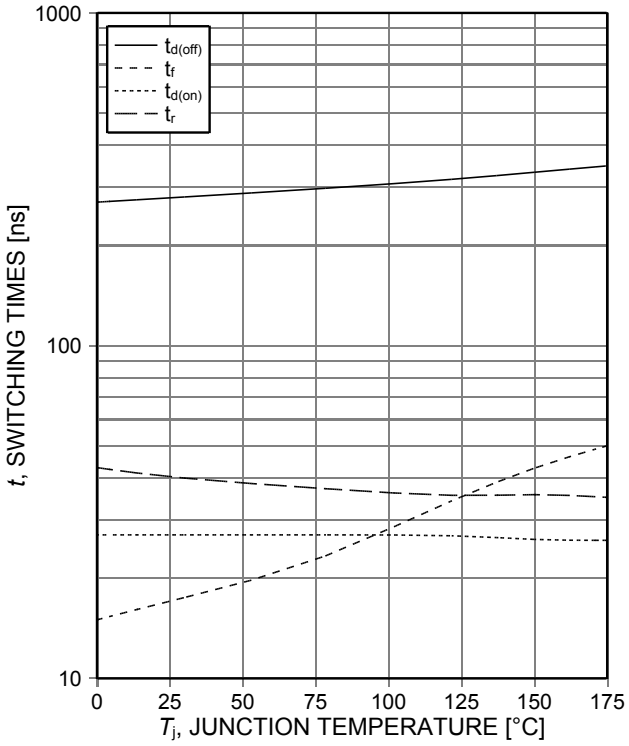

Figure 11. **Typical switching times as a function of junction temperature**
(ind. load, V_{CE}=600V, V_{GE}=15/0V, I_C=25A, r_G=23Ω, test circuit in Fig. E)

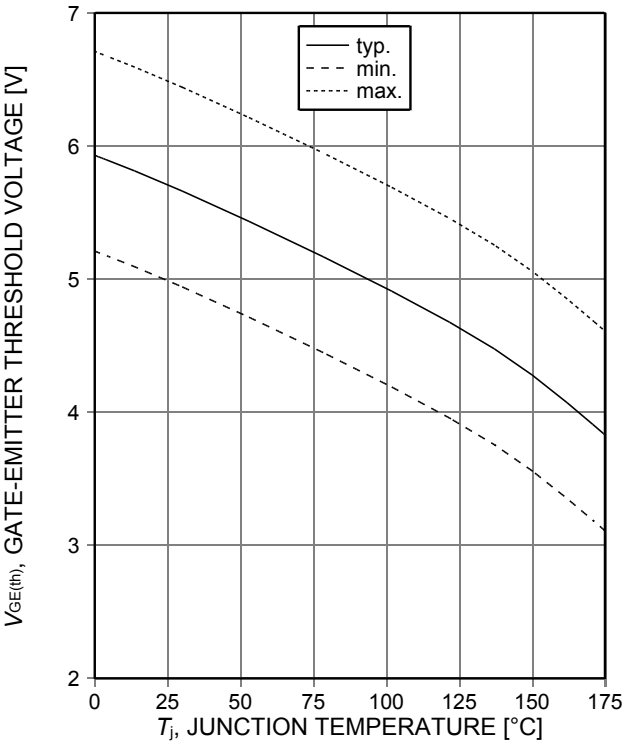

Figure 12. **Gate-emitter threshold voltage as a function of junction temperature**
(I_C=0.85mA)

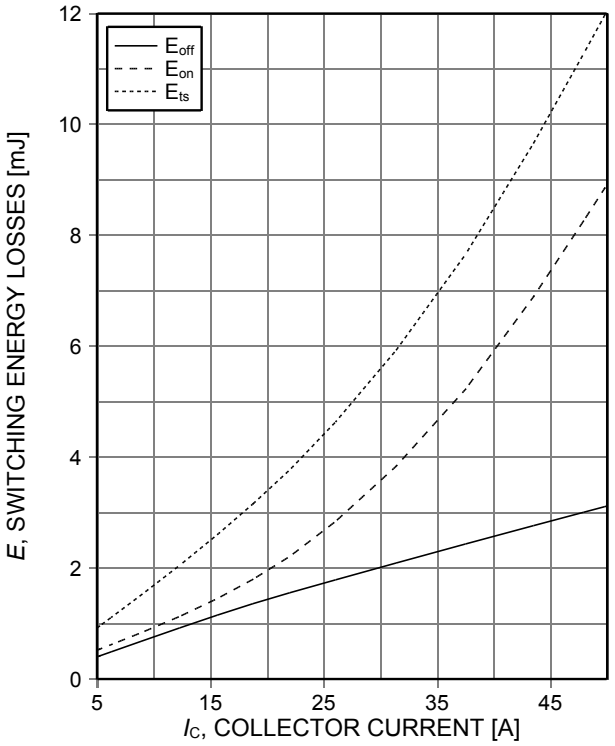

Figure 13. **Typical switching energy losses as a function of collector current**
(ind. load, T_j=175°C, V_{CE}=600V, V_{GE}=15/0V, r_G=23Ω, test circuit in Fig. E)

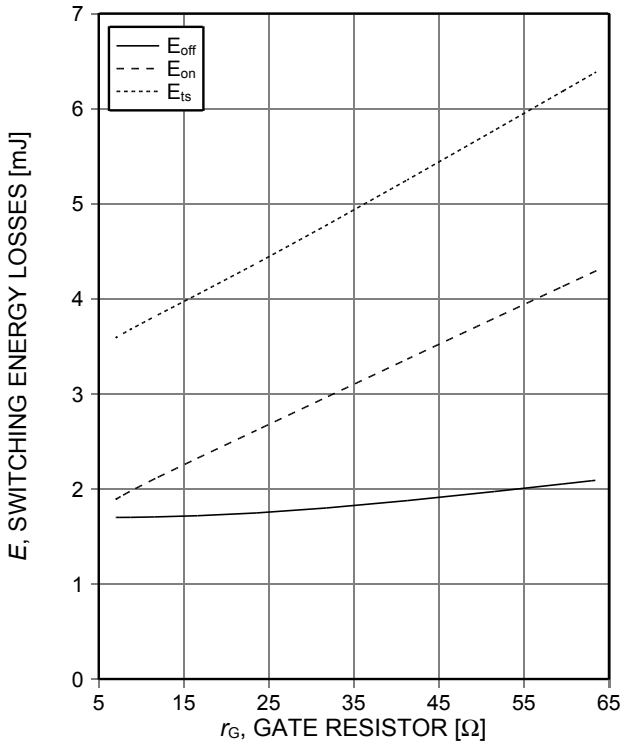

Figure 14. **Typical switching energy losses as a function of gate resistor**
(ind. load, T_j=175°C, V_{CE}=600V, V_{GE}=15/0V, I_C=25A, test circuit in Fig. E)

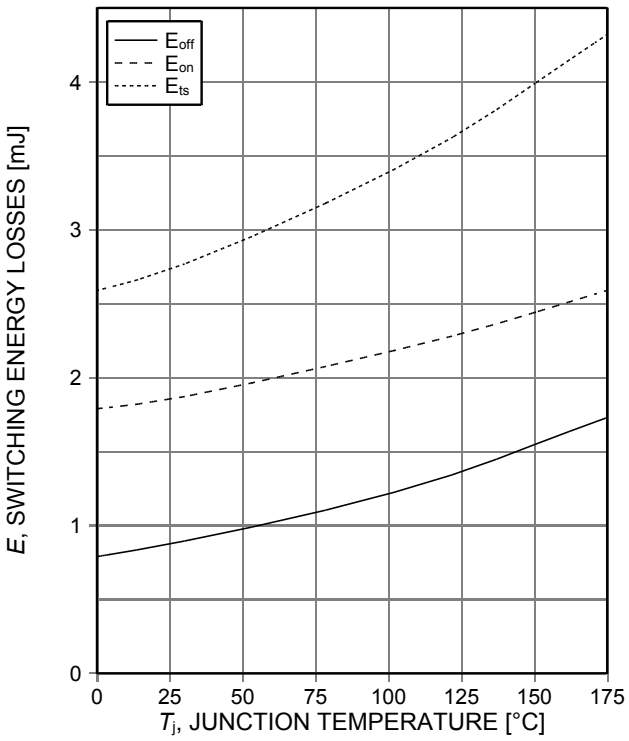

Figure 15. **Typical switching energy losses as a function of junction temperature**
(ind load, V_{CE}=600V, V_{GE}=15/0V, I_C=25A, r_G=23Ω, test circuit in Fig. E)

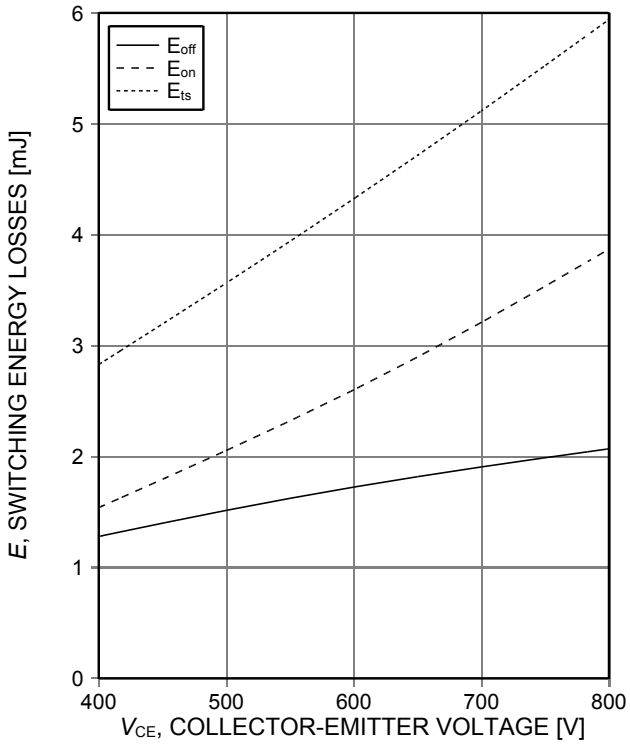

Figure 16. **Typical switching energy losses as a function of collector emitter voltage**
(ind. load, T_j=175°C, V_{GE}=15/0V, I_C=25A, r_G=23Ω, test circuit in Fig. E)

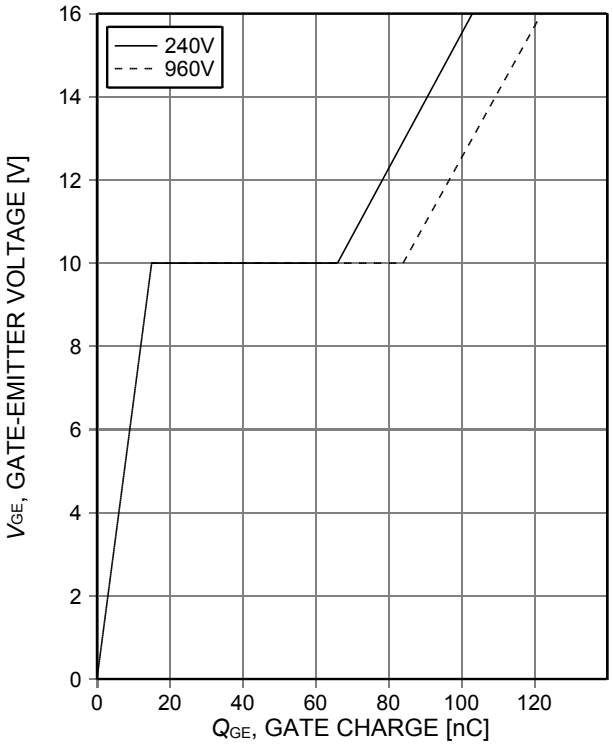

Figure 17. **Typical gate charge**
(I_C=25A)

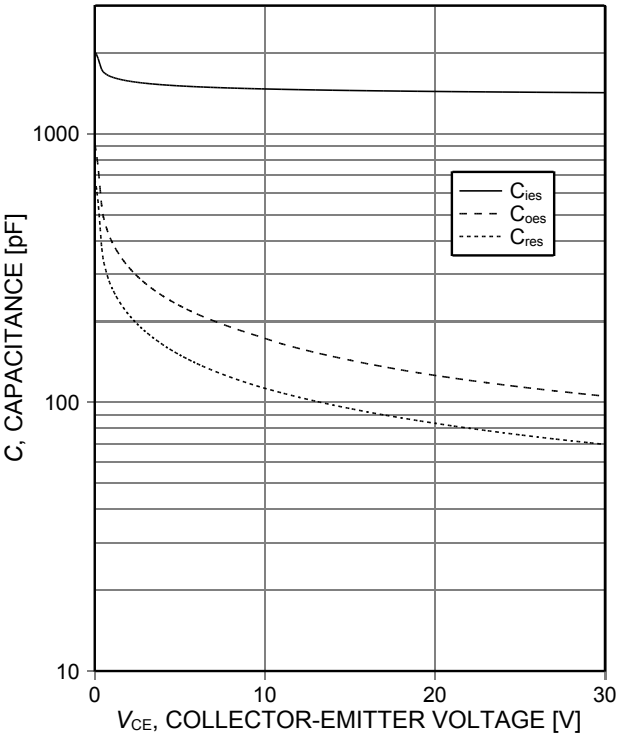

Figure 18. **Typical capacitance as a function of collector-emitter voltage**
(V_{GE}=0V, f=1MHz)

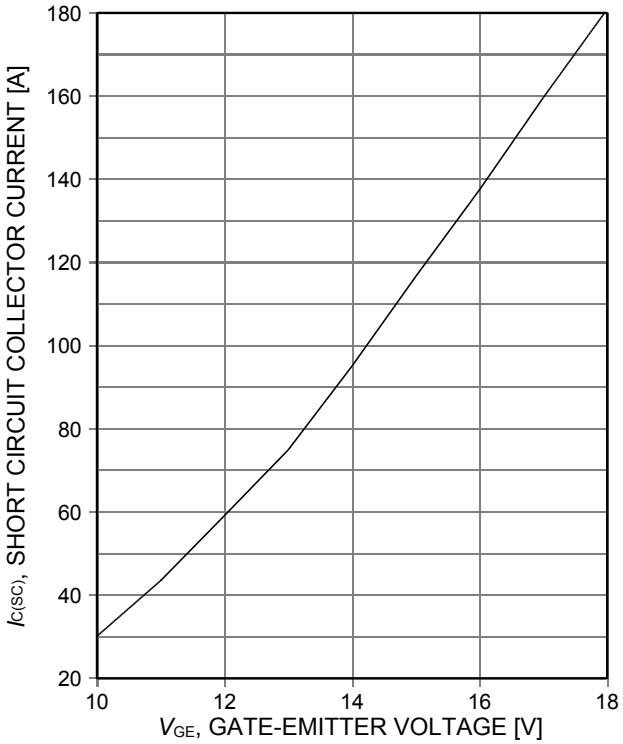

Figure 19. **Typical short circuit collector current as a function of gate-emitter voltage**
(V_{CE}≤600V, start atT_j=25°C)

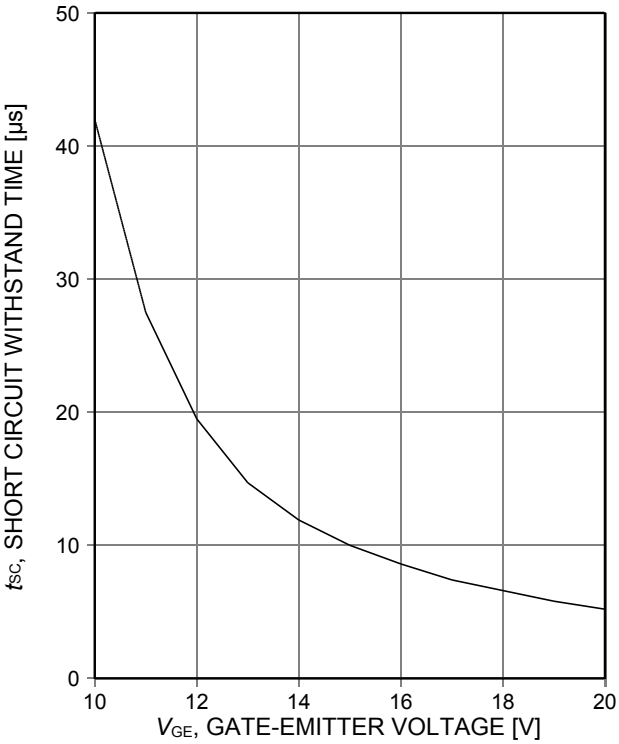

Figure 20. **Short circuit withstand time as a function of gate-emitter voltage**
(V_{CE}≤600V, start at T_j≤150°C)

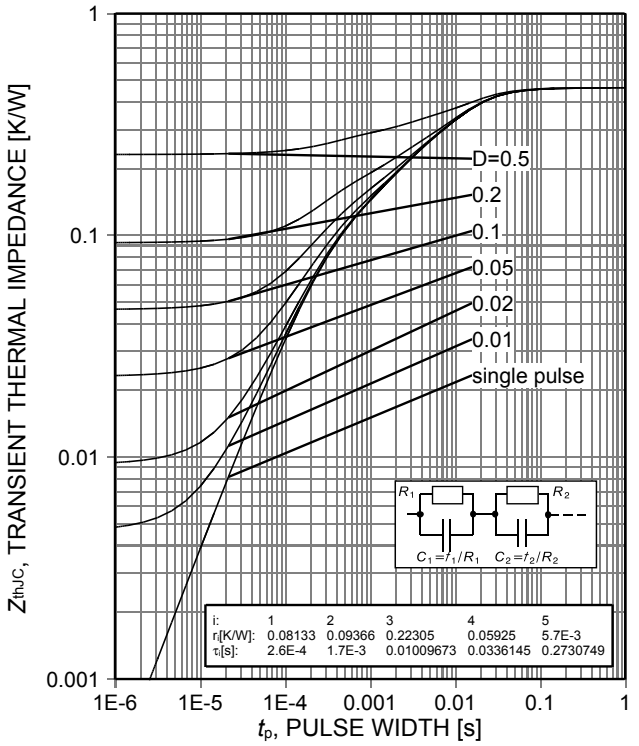

Figure 21. **IGBT transient thermal impedance** ($D=t_p/T$)

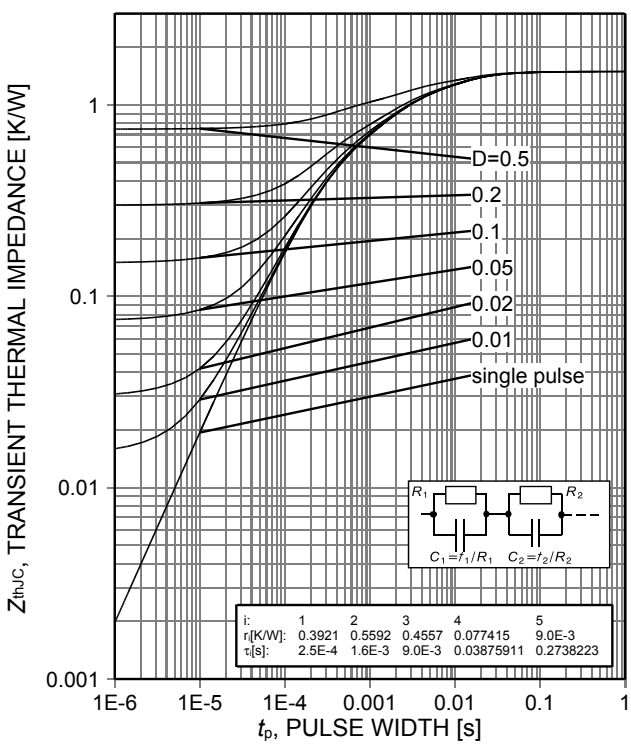

Figure 22. **Diode transient thermal impedance as a function of pulse width** ($D=t_p/T$)

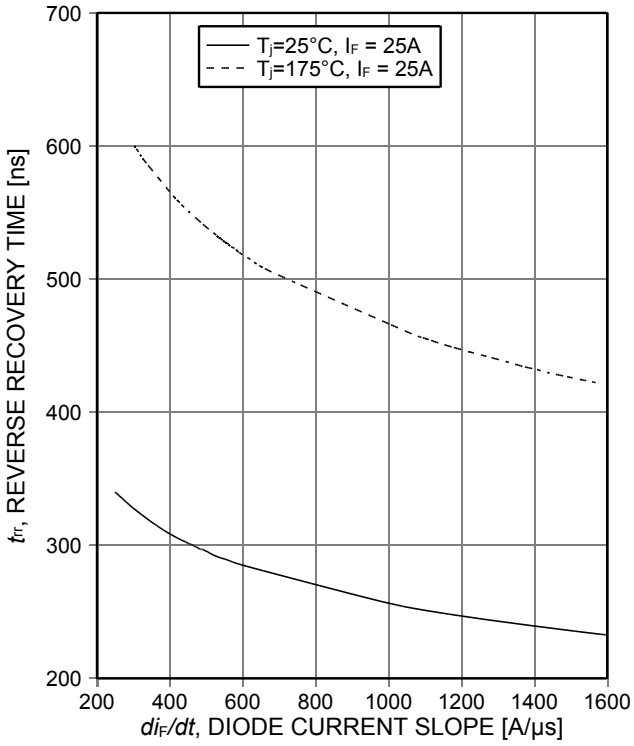

Figure 23. **Typical reverse recovery time as a function of diode current slope** (V_R=600V)

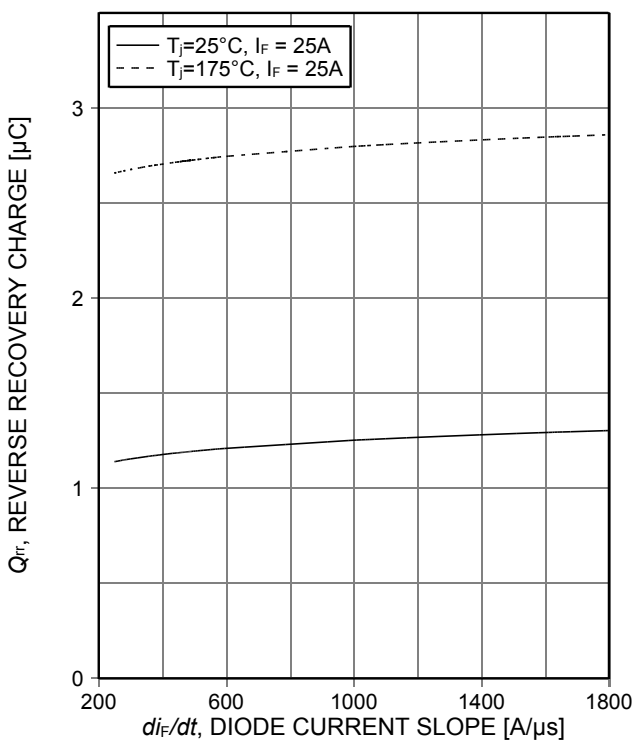

Figure 24. **Typical reverse recovery charge as a function of diode current slope** (V_R=600V)

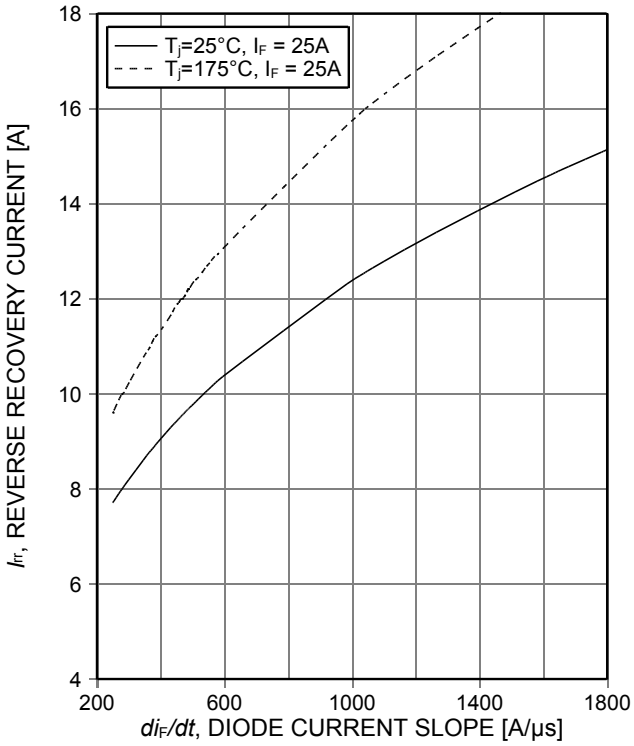

Figure 25. **Typical reverse recovery current as a function of diode current slope**
(V_R=600V)

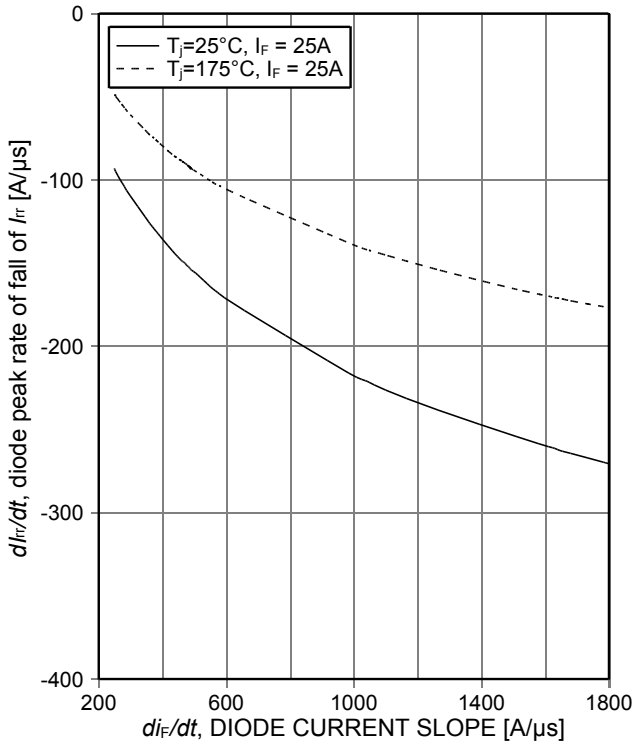

Figure 26. **Typical diode peak rate of fall of reverse recovery current as a function of diode current slope**
(V_R=600V)

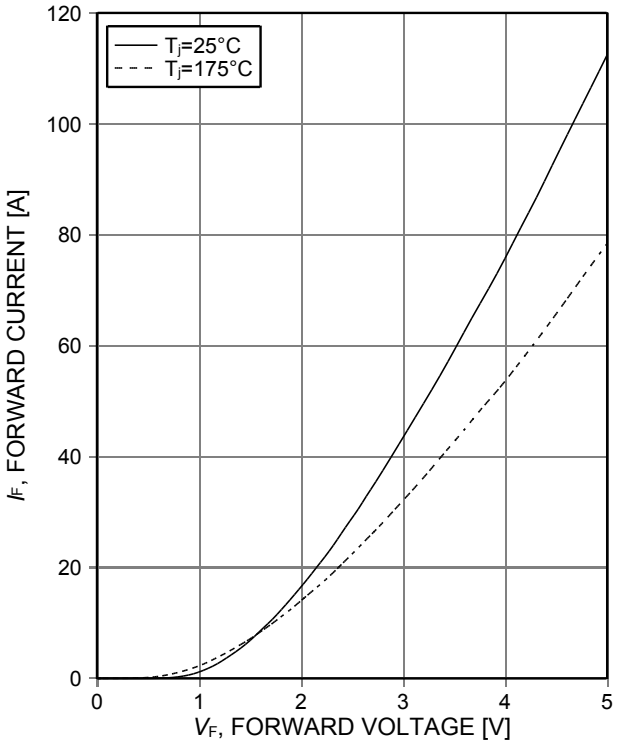

Figure 27. **Typical diode forward current as a function of forward voltage**

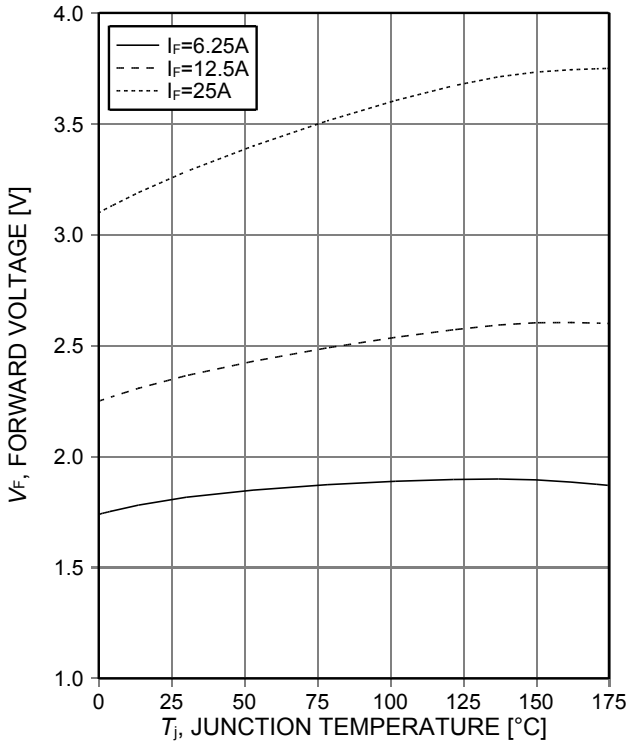

Figure 28. **Typical diode forward voltage as a function of junction temperature**

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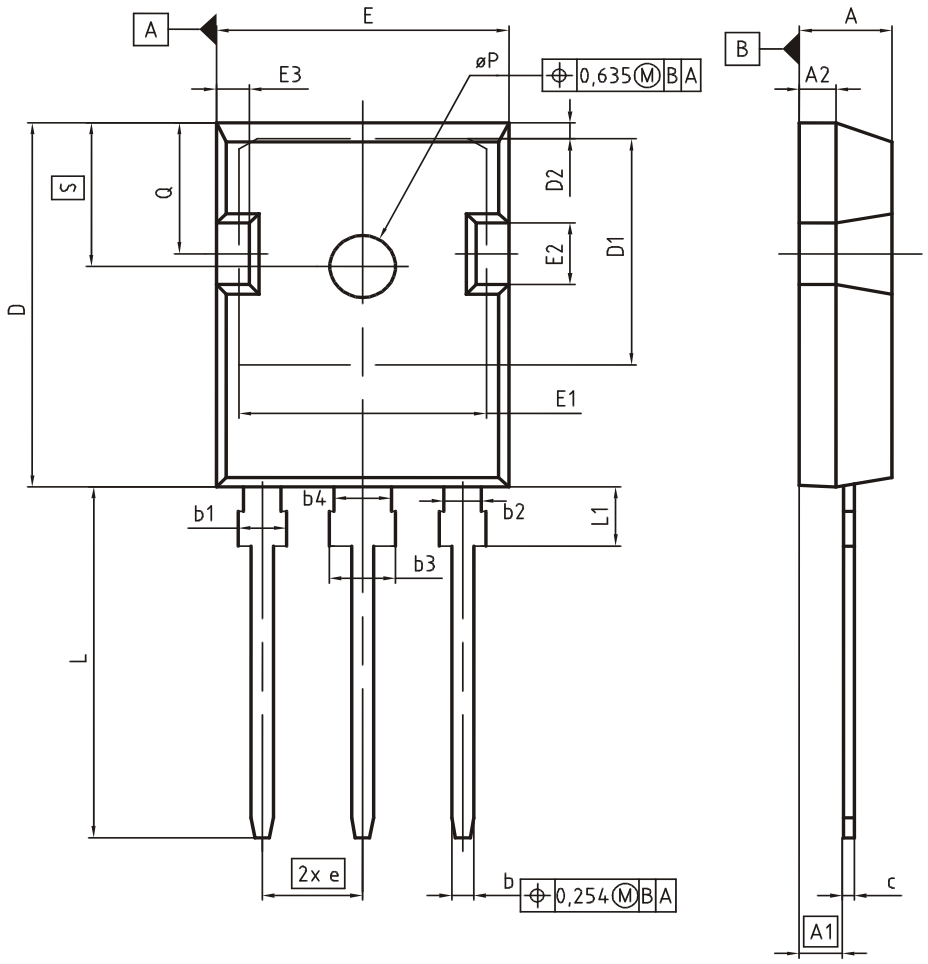

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.83	5.21	0.190	0.205
A1	2.27	2.54	0.089	0.100
A2	1.85	2.16	0.073	0.085
b	1.07	1.33	0.042	0.052
b1	1.90	2.41	0.075	0.095
b2	1.90	2.16	0.075	0.085
b3	2.87	3.38	0.113	0.133
b4	2.87	3.13	0.113	0.123
c	0.55	0.68	0.022	0.027
D	20.80	21.10	0.819	0.831
D1	16.25	17.65	0.640	0.695
D2	0.95	1.35	0.037	0.053
E	15.70	16.13	0.618	0.635
E1	13.10	14.15	0.516	0.557
E2	3.68	5.10	0.145	0.201
E3	1.00	2.60	0.039	0.102
e	5.44 (BSC)		0.214 (BSC)	
N	3		3	
L	19.80	20.32	0.780	0.800
L1	4.10	4.47	0.161	0.176
øP	3.50	3.70	0.138	0.146
Q	5.49	6.00	0.216	0.236
S	6.04	6.30	0.238	0.248

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EUROPEAN PROJECTION	
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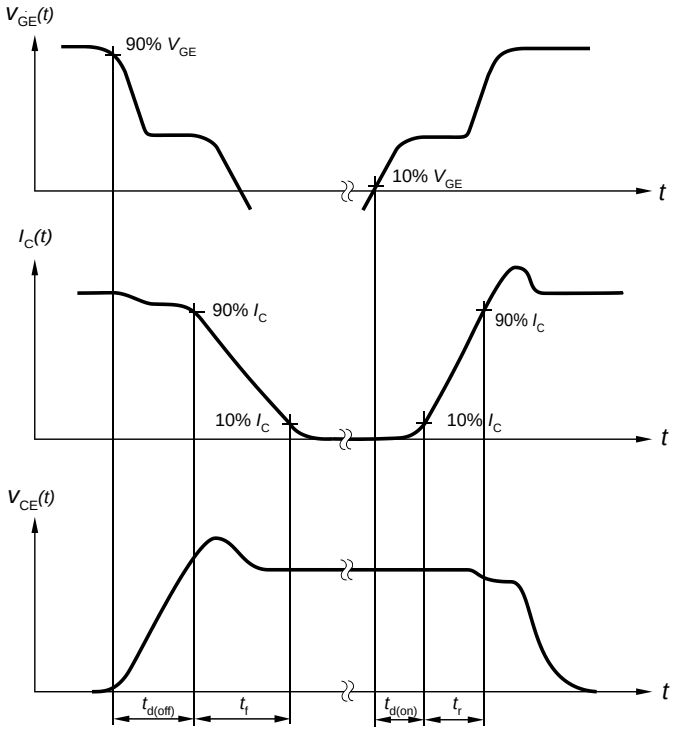

Figure A. **Definition of switching times**

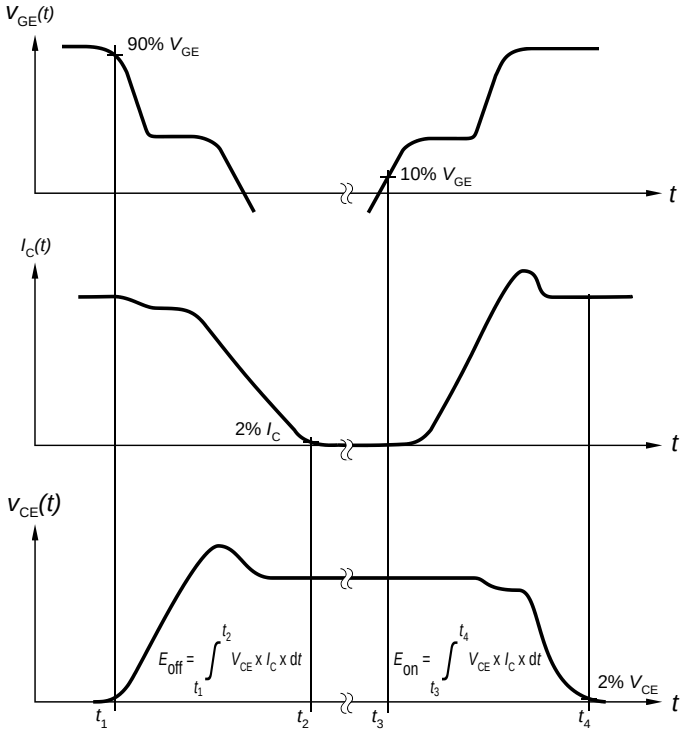

Figure B. **Definition of switching losses**

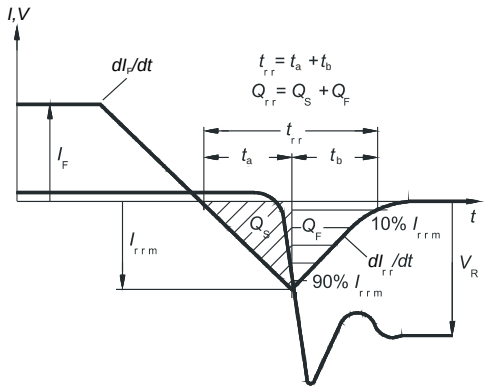

Figure C. **Definition of diode switching characteristics**

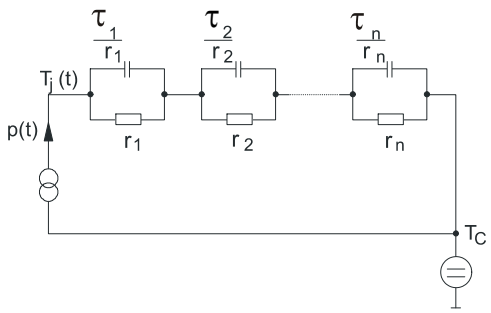

Figure D. **Thermal equivalent circuit**

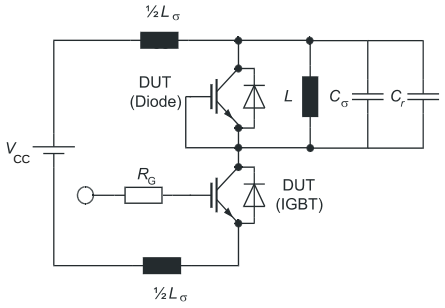

Figure E. **Dynamic test circuit**
Parasitic inductance L_σ,
parasitic capacitor L_σ,
relief capacitor C_r,
(only for ZVT switching)

Revision History

IKW25N120H3

Revision: 2014-12-01, Rev. 2.1

Previous Revision

Revision	Date	Subjects (major changes since last revision)
1.1	2009-11-27	-
1.2	2010-02-10	-
2.1	2014-12-01	Final data sheet

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